

Search Notes

Application/Control No.

10/766,910

Examiner

Len Tran

Applicant(s)/Patent under
Reexamination

YAMANE ET AL.

Art Unit

1725

SEARCHED

Class	Subclass	Date	Examiner
164	466	5/13/2005	LT
	502		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST and Palm	5/13/2005	LT